

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/541,071	FACCIO ET AL.
	Examiner Ellen Kim	Art Unit 2874

Search Notes



Application/Control No.

10/541,071

Examiner

Ellen Kim

**Applicant(s)/Patent under
Reexamination**

FACCIO ET AL.

Art Unit

2874

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)